

**Search Notes**

Application/Control No.

10/088,868

Examiner

Christopher L. Chin

Applicant(s)/Patent under  
Reexamination

LENZ ET AL.

Art Unit

1641

**SEARCHED**

Class	Subclass	Date	Examiner
Updated	Search	5/31/2005	CC
436	536		
436	538		
436	539		
436	540		
436	541	5/31/2005	CC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner